

Search Notes

Application/Control No.

10/821,969

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

WATSON ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	757, 850- 853, 836, 800, 801	6/10/2007	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR